

FORM PTO-1449

Sheet 1 of 1 (12/14/01)

INFORMATION DISCLOSURE CITATION IN AN APPLICATION

(Use several sheets if necessary)

DEC 14 2001

ATTY DOCKET NO.
0042-0455P

APPLICATION NO.
09/955,438

APPLICANT
IHAMA, Mikio et al

FILING DATE
September 19, 2001

GROUP
UNASSIGNED 1782

U.S. PATENT DOCUMENTS

EXAMINER'S
INITIAL

DOCUMENT NUMBER

DATE

NAME

CLASS

SUB
CLASS

FILING DATE
IF APPROPRIATE

HW

5 4 9 4 7 8 9

1996-02-27

DAUBENDIEK et al.

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TC 1700

FOREIGN PATENT DOCUMENTS

DOCUMENT NUMBER

DATE

COUNTRY

CLASS

SUB
CLASS

TRANSLATION

YES

NO

OTHER DOCUMENTS

(Include Name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.) date, page(s), volume-issue number(s), publisher, city and/or country where published.

EXAMINER

DATE CONSIDERED

12/1/2001

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**INFORMATION DISCLOSURE CITATION
IN AN APPLICATION**

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ATTY DOCKET NO.
0042-0455PAPPLICATION NO.
09/955,438APPLICANT
Mikio IHAMA et al.CONF. NO.
6673FILING DATE
September 19, 2001GROUP
1752**U.S. PATENT DOCUMENTS**

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
AW	5 4 9 4 7 8 9	1996-02-27	DAUBENDIEK et al.			
	6 3 3 8 9 4 0 B1	2002-01-15	MIYAZAWA et al.			
	5 6 1 2 1 7 5	1997-03-18	Eshelman et al.			
	5 6 1 2 1 7 7	1997-03-18	Levy et al.			
	5 6 1 2 1 7 6	1997-03-18	Eshelman et al.			
	5 6 1 4 3 5 9	1997-03-25	Eshelman et al.			
	5 6 2 9 1 4 4	1997-05-13	Daubendiek et al.			
	5 6 3 1 1 2 6	1997-05-20	Daubendiek et al.			
	5 6 9 1 1 2 7	1997-11-25	Daubendiek et al.			
	5 7 2 6 0 0 7	1998-03-10	Deaton et al.			
	5 6 9 8 3 8 7	1997-12-16	Reed et al.			
	5 7 2 3 2 7 8	1998-03-03	Jagannathan et al.			
	6 0 0 7 9 7 7	1999-12-28	Nishikawa			
	6 1 0 0 0 1 9	2000-08-08	Brust et al.			
AW	6 1 5 3 3 7 0	2000-11-28	Maruyama et al.			

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FOREIGN PATENT DOCUMENTS

DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB CLASS	TRANSLATION
					YES NO

OTHER DOCUMENTS

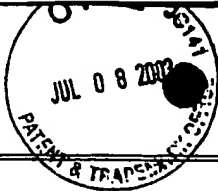
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Mikio IHAMA et al.

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1752

U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	Kind	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
AW	US 6,544,725	B2	2003-04-08	Morimoto			
AW	US 5,496,694		1996-03-05	Kikuchi et al.			
AW	US 6,432,626	B1	2002-08-13	Sugimoto et al.			
	US						
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FOREIGN PATENT DOCUMENTS

	Office	DOCUMENT NUMBER	Kind	DATE	COUNTRY	CLASS	SUB CLASS	TRANSLATION	
								YES	NO

OTHER DOCUMENTS

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